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|-----------------------------------|-------------------------|---|-------------|
| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | 10/520,080 | DOUCOURE ET AL. | |
| | Examiner | Art Unit | Page 1 of 1 |
| | Krishnan S. Menon | 1723 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-5,718,957 | 02-1998 | Yokoe et al. | 428/36.91 |
| * | B | US-5,198,505 | 03-1993 | Sipsas et al. | 525/326.2 |
| * | C | US-5,053,132 | 10-1991 | Sirkar, Kamalesh K. | 210/500.23 |
| * | D | US-5,130,024 | 07-1992 | Fujimoto et al. | 210/500.36 |
| * | E | US-5,158,680 | 10-1992 | Kawai et al. | 210/321.61 |
| * | F | US-3,935,096 | 01-1976 | Eng et al. | 423/181 |
| * | G | US-5,437,900 | 08-1995 | Kuzowski, Stanislaw L. | 428/36.1 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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